

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination NIWA ET AL.	
		Examiner Gary Chin	Art Unit 3661	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2005/0090956 A1	04-2005	Ogawa, Fumiharu	701/037
*	B	US-2006/0142916 A1	06-2006	Onuma et al.	701/038
*	C	US-7,092,808	08-2006	Lu et al.	701/70
*	D	US-7,085,637	08-2006	Breed et al.	701/38
*	E	US-5,027,302	06-1991	Asanuma et al.	701/48
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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